

<b>Notice of References Cited</b>	Application/Control No. 10/602,678	Applicant(s)/Patent Under Reexamination SEKI ET AL.	
	Examiner Dustin Nguyen	Art Unit 2154	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0026532	02-2002	Maeda et al.	709/250
*	B	US-6,785,720	08-2004	Seong, Goan-soo	709/220
*	C	US-7,200,683	04-2007	Wang et al.	709/250
*	D	US-6,640,239	10-2003	Gidwani, Sanjay M.	709/203
*	E	US-2002/0194596	12-2002	Srivastava, Gopal K.	725/37
*	F	US-2003/0018753	01-2003	Seki, Ryuken	709/219
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.